

Denton 635 Sputter SOP



1. Scope

1.1 This document provides operating procedures for the Denton 635 automated sputter system..

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3. Reference Documents

3.1 Referenced within this Document

3.1.1 None.

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3.2 External Documents

3.2.1 None.

4. Equipment and/or Materials

- 4.1 Denton 635 sputter system, pre-installed targets, heated or cooled stage, Ar, N2 and O2 gasses and substrate transport pallet
- 4.2 Wafer/sample
- 4.3 Glass slide for metrology data
- 4.4 Kapton tape

5. Safety

- 5.1 Follow all Nanofab safety procedures.
- 5.2 With heated stage pallet must cool to < 150 C for transfer.
- 5.3 Be cautious when removing hot wafers, substrate or pallet.



5.4 Allow time for cooling in vented load-lock until cool enough to handle safely.

6. Setup Procedures

6.1 Reserve Equipment

- 6.1.1 Reserve and enable Denton 635 sputter system in CORAL
- 6.1.2 Pre-coordinate sputter process with nanofab staff so that your required master recipe and/or system target and heated/cooling chuck configuration is ready.

6.2 Log-in and Verify System Status

6.2.1 If necessary, login as "operator" using password "operator".

Auto		System Status	
Recipe	Abort	Current Step:	
Auto Pump Load Lock Auto Vent	Load Lock Auto Pump	Next Step:	Edit/Create Deposition
Pressur 6.3e- Manom 0.0	e ∙008 _{Torr} eter ™Torr	Recipe Name Sequence Name SOP Cr 100W Au 400W.dat LL Vent Current Step 14 of 14 Process Time Run Number 00:12:21 685	Sputter
Ar Gas 1 Gas 2	N2 Gas 3 Cas	Au 4" Cr 4" Ai 3" Ti 3" 4 C1 C2 C3 C4 DC1 DC1 DC1 DC1 DC1	
	Fork Up		
	1	Position Control Position Set (#-1090) 1000 Pressure Set (mT orr) 5.0 Pressure Set (mT orr) 5.0	
Login	Operator		

6.2.2 On Operator screen verify main chamber Pressure is less than 1e-006 Torr, see Figure 1

Figure 1, Operator Screen

- 6.2.3 On instrument rack below keyboard verify cryo temperature is 20° K or less on red LED display for adequate vacuum pumping capability.
- 6.2.4 All cathodes must have a target installed prior to performing any sputtering process. The installed target material and cathode number is displayed on the screen above the cathode icon.

6.3 Check and Edit Deposition Recipe

- 6.3.1 Option to speed up loading, jump to section 7.1 Venting Load Lock only, then return here to edit recipe.
- 6.3.2 On Operator screen click on Edit/Create button to edit the deposition time on deposition sputter recipe.



6.3.3 After a short delay, a list of deposition recipes (*.dep files) will be displayed. Select the one that corresponds to the deposition you will run and click open in lower right corner. See figure 2

🚺 Open		manipulai (tan 1		any mark that
Computer	OS (C:) CIMPLICITY Integrity_36 Deposition			
Orozoize × New folder				
organize • New rolder				
Microsoft Excel	Name	Date modified	Туре	Size
	CR 4IN CATH2 100W.dep	8/3/2016 1:37 PM	DEP File	1 KB
🔆 Favorites	AU 4IN CATHL 400W.dep	8/3/2016 1:22 PM	DEP File	1 KB
Nesktop	AL 3IN CATH3 400W.dep	8/1/2016 4:00 PM	DEP File	1 KB
😹 Downloads	TI 3IN CATH4 100W.dep	7/28/2016 11:42 AM	DEP File	1 KB
🝊 OneDrive	AU 4IN CATHI 100W.dep	7/27/2016 10:09 AM	DEP File	1 KB
Recent Places	SIO2-TI 3IN 200W MULTH0.dep	7/22/2016 8:48 AM	DEP File	1 KB
	TI 3IN CATH4 200W.dep	7/21/2016 3:58 PM	DEP File	1 KB
; Libraries	RF SIO2 3IN 200W CATHB.dep	7/21/2016 3:11 PM	DEP File	1 KB
Documents	RF SIO2 3IN 100W CATHB.dep	7/21/2016 3:10 PM	DEP File	1 KB
👌 Music	SIO2-TI MULTI PLAYER.dep	7/20/2016 10:41 AM	DEP File	1 KB
Pictures	BIAS 100WATTS AR.dep	7/19/2016 12:09 PM	DEP File	1 KB
Videos	CR 4IN CATH2 400W 0_4MT.dep	7/19/2016 11:55 AM	DEP File	1 KB
	CR 4IN CATH2 400W 1MT.dep	7/18/2016 2:24 PM	DEP File	1 KB
15 Computer	CR 4IN CATH2 400W 15 MT.dep	7/18/2016 2:10 PM	DEP File	1 KB
🕰 OS (C:)	CR 4IN CATH2 400W 10 MT.dep	7/18/2016 1:45 PM	DEP File	1 KB
USB DISK (E)	CR 4IN CATH2 400W.dep	7/18/2016 12:15 PM	DEP File	1 KB
Removable Disk (F:)	AU 4IN CATHL 200W.dep	7/15/2016 2:33 PM	DEP File	1 KB
RECOVERY (Y:)	AL 3IN CATHS 100W.dep	7/12/2016 1:48 PM	DEP File	1 KB
	CATHODE 1 100W.dep	7/12/2016 1:45 PM	DEP File	1 KB
👊 Network	MANOMETER TEST .dep	6/9/2016 5:31 PM	DEP File	1 KB
	UNTITLED MANOMETER CHECK	6/9/2016 3:03 PM	DEP File	1 KB
	BIAS TEST WATER COOLED STAGE.dep	6/3/2016 3:36 PM	DEP File	1 KB
	UTAH ATP WATER COOLED STAGE TEST dop	6/3/2016 10:38 AM	DEP File	1 KB
	HEATER TEST WITH COOL RATE dep	6/3/2016 9:35 AM	DEP File	1 KB
	HEATER TEST.dep	6/3/2016 9:31 AM	DEP File	1 KB
	UTAH ATP CATHODE 4 UNIFORMITY dep	6/2/2016 2:25 PM	DEP File	1 KB
	UATH ATP CATHODE 3 UNIFORMITY dep	6/2/2016 1:57 PM	DEP File	1 KB
	UITAH ATP CATHODE 2 UNEORMITY day	6/2/2016 1-03 PM	DEP File	1 KB
	ITAH ATE CATHODE 1 UNEOPMITY 100 W PIAS date	6/2/2016 12/24 DM	DED Ella	1 10
	DIAS TEST den	6/2/2016 11:57 AM	DED Ella	1 / 0
	VAT DESCRIPT TEET day	6/1/2016 E-50 DM	DED Ella	1 KD
	ATD GAS ELOW TEST dee	6/1/2016 5-20 DM	DED EIL-	1 KD
	CATHODE1.2 21M day	2/20/2016 2/40 PM	DED Eile	1 KD
		2/20/2010 JAS PM	DEP THE	1 KD
	CATHODE 1 600W SMT 15MB4-75W BIAS 2MB4.dep	2/29/2010 11:52 AM	DEP File	1 KD
	CATHODE 3 600W DC3 SMT 15MB475W BLAS 2MB4.0EP	2/29/2010 11:51 AM	DEP File	1 KB
		2/25/2010 11/45 AM	DEP FILE	1 KB
	CATHODE1800W SMI120MB4.dep	2/29/2016 11302 AM	UCP File	1 KB
	CATHODE 1 600W DC2 SMT 30MIN-7SW BIAS 2MIN	2/29/2016 10:56 AM	DEP File	1 KB
	CATHODE 3 600W SMT 30MIN-75W BIAS 2MIN.dep	2/29/2016 10:30 AM	DEP File	1 KB
sue Dat	ne: AU 4IN CATHE 400W.dep			

Figure 2, Example, Deposition Recipe List

- 6.3.4 An Excel based deposition recipe will be displayed with each column representing a processing step. The **deposition step** will typically be the **second to last step and the top row is deposition time in seconds** which is the only entry authorized for operator editing. The deposition step can also be identified by **shutter OPEN** parameter in the deposition column. See Figure 3.
- 6.3.5 Check and edit the time if necessary. (based upon your desired thickness and the sputter deposition rate as found in the design a process software on the Nanofab website)
- 6.3.6 Then press SAVE button and click yes to overwrite file.

Note: Additional editing may invalidate the deposition recipe within the master recipe and result in process error or unexpected result.

- 6.3.7 Use the red close button (not the X) to close and exit the Excel recipe worksheet and click yes to overwrite and to close all sheets.
- 6.3.8 Repeat the time editing process for a different second thin film layer, if desired.
- 6.4 The stage must have a pallet in place prior to performing any sputtering process.

⊟ 5° ¢	≯ -	÷				DentonSput.	kls (Rea	d-Only] [Corr	npatibil	ity Moo	le] - Exe	el	1
File Ho	me	Insert Page Layout Form	ulas	Data	Review	View Ad	ld-ins	Tea	m	Q Tel	l me wł	nat you	want t	o do
		Step Number	T000	T001	T002	T003	T004	T005	T006	T007	T008	T009	T010	T011
5	5 0	Step Time (sec)	10	10	10	166	5							
Nour	1	Rotation Velocity (constant rot %)		50	50	50								
New	2													
Open	3	Min Vacuum Setpoint (Torr)	1.0E-06											
	4	Chamber Heat Setpoint (°Celcius)												
Save	5	Heater Rate (Deg/min)	<u> </u>											
	6	Heater Cooling Rate (Deg/min)												
Delete File	7	Ignition Pressure (mTorr)												
	8	VAT Throttle Control		YES	YES	YES								
Save As	9	VAI Position Setpoint	I		-									
	10	VAT Pressure Setpoint		5	5	5								
	11	Gas 1 - Setpoint (sccm)		35	35	35								
Insert Column	12	Gas 2 - Setpoint (sccm)												
	13	Gas 3 - Setpoint (sccm)												
Delete Column	14	Gas 4 - Setpoint (sccm)												
	15	DC 1 Setpoint			400	400								
	16	DC 1 Cathode		1	1	1								
	17	DC 1 Shutter				Open								
	18													
	19	DC 2 Setpoint												
File Name	20	DC 2 Cathode												
AU 4IN CATH1 40	21	DC 2 Shutter												
	22	RF 1 Setpoint												
	23	RF 1 Cathode												
	24	RF 1 Shutter												
01	25	Bias Setpoint												
Close	26	Plasma Gas to Control												
	27	Plasma Wavelength to Monitor												
	28													
	25	Plasma Setpoint												
	30	Control Mode												
	31	PID Proportional Gain												
	32	PID Integral Rate												
	33	PID Derivative												
	34	PID Lower Clamp												
	35	PID Upper Clamp												
	36	PID Sample Period												
	37													
	38													
	35													
	40	Gas PID upstream control												
	41	Gas PID Master Gas												
	42	Gas PID Pressure												
	43		1											
	44	Comments	1	a comment		166 secs for 200 nm								
	45		1											
	46	End Process (Yes)					YES							
		Check Logic Validity												



7. Sputter Procedure, Automated Operation

7.1 Venting Load Lock

- 7.1.1 On Operator screen, the AUTO button should be green, if not click the AUTO button.
- 7.1.2 Click on the Load Lock Auto Vent button below the AUTO button. The System Status box will show the steps being performed and pressure. The load lock door will open when complete.

7.2 Loading Wafers or Substrates

7.2.1 Carefully remove the transport pallet and place it on a worktable for loading, it will either be on the transfer arm or in the bottom of the load lock.

Note: The transfer arm is a cantilever design, be careful to not bend or deflect the arm.



- 7.2.2 The transport pallet for the water-cooled stage is a solid round aluminum disc with a recess for a 200 mm wafer. It assists with heat conduction from the substrate into the water-cooled stage in the deposition chamber. Be careful not to drop or damage this pallet as damage can both reduce heat transfer during deposition and cause handling and transfer problems.
- 7.2.3 For lift-off applications, place wafers or substrates and a metrology glass slide directly on the pallet.
- 7.2.4 For non-critical temperature applications, nanofab staff may provide a 200 mm wafer to place on the pallet and minimize deposition build-up, insert into recess then place wafers or substrates and a metrology glass slide on the wafer.
- 7.2.5 Very carefully move the pallet from the work-table and place on the forked transfer arm, positioning as close as possible to the left side of fork.

Note: The samples must be centered on the pallet so the pallet will balance on the fork.

7.2.6 Close the load lock door and secure the latch to hold it closed.

7.3 Starting Auto Deposition Process

- 7.3.1 The Master Recipe combines and includes the following steps: Load-lock Auto Pump, Auto Transfer (load pallet into chamber), one or more auto deposition recipes, Auto Unload and Load Lock Auto Vent. The Master Recipe is limited to 200 steps and created by nanofab staff.
- 7.3.2 On Operator screen, click on Master Recipe button, then in pop-up window Open button.
- 7.3.3 Select the Master Recipe that includes the deposition recipe(s) you want to run, then close the pop-up window.
- 7.3.4 Verify the desired Master Recipe name is displayed on the Operator screen in the System Status box.
- 7.3.5 Click on the **Start** button.
- 7.3.6 Watch the steps in the System Status box and after the load lock starts pump down, verify load lock pressure is decreasing. If it's not decreasing check that the load lock door latch has the door closed. Shortly after the vacuum starts to drop, the latch will release and cause a thud sound and the vacuum will hold the door closed.

Caution: do not re-latch load lock!

- 7.3.7 The wafer will automatically be transferred into the process chamber, and the software will pump down the chamber, flow sputter gases, set the correct pressure, pre-sputter, and open the shutter for the correct time.
- 7.3.8 Once the deposition steps begin, the recipe column will be displayed on the right side of the screen. The Chamber viewport shutter can be opened momentarily to observe plasma and pallet. Do not wedge viewport shutter open or view for extended time.
- 7.3.9 Enter the Process Run Data in CORAL.
- 7.3.10 When deposition is complete, the sample will be automatically returned to the load lock. After the load lock has vented and opened, remove the pallet and place on a worktable. If the heated stage has been used, you must wait until the substrate is less than 40 Celsius to handle it.



- 7.3.11 Remove your substrates and return the pallet to the bottom of the load lock if you're done processing.
- 7.3.12 Close the load lock door and secure the latch to hold it closed.
- 7.3.13 Click on the Load Lock Auto Pump button below the AUTO button. Watch the steps in the System Status box and after the load lock starts pump down, verify load lock pressure is decreasing.
- 7.3.14 Take thickness and resistivity measurements then record process settings and measurements in Coral and disable the tool.

Note: the Load lock and pallet should be left under vacuum to minimize pump time for next process run.

8. Denton 635 Configuration and Capabilities

8.1 Four Confocal Cathodes

- 8.1.1 Standard targets 4" Au, 4" Cr, 3" Al, 3" Ti.
- 8.1.2 Other targets can be installed, exchanging with an existing "standard" target by arrangement with staff and system availability. A 1 hour technician time charge will be required for target swap and return to standard target, with chamber pump down targeted for an un-used overnight period.
- 8.1.3 Cathodes and targets in 4" diameter were specified to provide +/- 5% or better uniformity on 200 mm wafer/pallet area. The 3" cathodes with current throw distance position are also providing 5% or better uniformity.
- 8.1.4 Film thicknesses are controllable from a few nm to hundreds of nm with power and time parameters.

8.2 Sputter Power Supplies

- 8.2.1 DC1 can operate in DC or Pulsed DC for reactive sputtering of metallic targets for higher deposition rate than provided by RF. Local configuration required, see staff.
- 8.2.2 DC2, basic DC supply, primary use co-sputtering.
- 8.2.3 RF1, auto-tuning RF supply for sputtering non-conductive targets or co-sputtering.
- 8.2.4 Recipe-switch control of any supply to any cathode, 5 second minimum no-load switch time required. Includes simultaneous operation of 2 or 3 supplies for co-sputtering.

8.3 Substrate Sputter Pre-clean with RF2 Supply

8.3.1 Thermal oxide removal rate ~ 11 nm/min at 100 W Ar gas, 33 nm/min at 300 W.

8.4 Substrate Rotation, 50 % = 13 RPM

8.5 Cryo Pumped Deposition Chamber

- 8.5.1 Typical base pressure $< 5 \times 10^{-8}$ Torr.
- 8.5.2 Auto-Regen automated process available for over-night cryo pump regen's.

8.6 Chamber Pressure Range < 1-90 mT controllable with APC and 100 sccm Ar MFC controller



8.7 Water-cooled Stage

- 8.7.1 Standard configuration is water-cooled stage installed and using aluminum pallet.
- 8.7.2 Supports liftoff deposition at 100-200W deposition power.

8.8 Heated Stage (option in place of water cooled stage)

- 8.8.1 Heated stage can provide substrate heating up to 500° C (heated stage installed) with proper substrate and transport pallet.
- 8.8.2 Open-center stainless steel ring transport pallet required.
- 8.8.3 Higher temperatures must use graphite or Si wafer with SS pallet.
- 8.8.4 Can be installed/removed by staff for configuration charge, estimated 1.0 to 1.5 hour each change (2 required).
- 8.8.5 Requires post deposition cool-down for wafer transfer plus cooling time to arranged temperature for subsequent user under reservation time if not changed back to water cooled stage.
- 8.8.6 Cool-down prior to conversion to cooled stage
- 8.8.7 Best to schedule for un-reserved time following heated run

8.9 PEM Controllable Reactive Sputtering (Nitrogen or Oxygen)

- 8.9.1 Plasma Emission Monitor (PEM) available for each cathode (hardware enabled by staff in chamber).
- 8.9.2 PEM control system modulates reactive gas flow (N2 or O2) to maintain constant intensity.
- 8.9.3 Characterization of selected intensity and spectra to resulting film properties required for each application, contact staff.
- 8.9.4 Uses pulsed DC supply operation to minimize arcing and maximize sputter rate of metallic targets.

9. Sputter Coating on PDMS, SylGard 184 only

- 9.1 Complete an NMR form for each occurrence of sputter coating on PDMS Sylgard 184. This involves staff for approval and provides notification to staff of non-standard material processing.
- 9.2 PDMS preparation
 - 9.2.1 Vacuum bake-out oven conditioning in VWR xxx oven
 - 9.2.1.1 Set oven temperature adjust knob to heat to 250°C
 - 9.2.1.2 Turn on oven vacuum and allow evacuation until gauge is ~ 24 to 26 inHg
 - 9.2.1.3 Open vent slightly until vacuum reading drops by 2 inHg i.e. was 25 and drops to 23 with slight vent opening
 - 9.2.1.4 Apply in-use label on oven and bake out empty for 24 hours to minimize Si oil in oven

- 9.2.2 Vacuum bake out PDMS
 - 9.2.2.1 Following empty oven bake out above, set temperature to 200°C
 - 9.2.2.2 Close off vacuum, vent and open oven and place PDMS on fresh foil in oven
 - 9.2.2.3 Close door, close vent, open vacuum and verify vacuum greater than 23 inHg
 - 9.2.2.4 Apply in-use label on oven and bake out PDMS for 24 hours minimum
 - 9.2.2.5 Shut off oven switch, vent oven and remove baked PDMS sample.
- 9.2.3 Plasma Treatment with Enercon Dyne-A-Mite
 - 9.2.3.1 Plasma treat surfaces to be sputter coated with Enercon Dyne-A-Mite (for better adhesion with the metal layers to be deposited)
- 9.2.4 Load the PDMS on fresh foil into the transport box and get staff approval on a chemical tag before moving to the sputtering system
- 9.2.5 Denton 635 sputter coating, supplemental instruction
 - 9.2.5.1 Place the foil with the PDMS substrates on top of the metal pallet of the Denton 635, wafer insert should be removed for better cooling

Caution: Be conscious of risk for silicone oil contamination on gloves and transfer to other surfaces, change gloves as needed and use foil to protect surfaces such as work tables, etc

- 9.2.5.2 Typically a custom recipe should be created to run at 50-100 W power level and with cooling steps to avoid over-heating PDMS, contact staff for recipe
- 9.2.5.3 Using custom master recipe, run PDSM sputter coating
- 9.2.5.4 After PDMS sample has been coated, unload to fresh foil in preparation for removing from cleanroom
- 9.2.5.5 Make sure to place pallet back onto transfer fork in load-lock
- 9.2.5.6 Load and run master recipe "RF Clean 300WO2-Ar" for 180 seconds to decontaminate sputter chamber and transport pallet

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Rev	Date	Originator	Description of Changes
1	08 Aug 2016	S. Pritchett	Initial SOP
2	12 Apr 2017	S. Pritchett	Incorporate mark-ups
3	14 Mar 2018	S. Pritchett	Add PDMS processing steps

10. Revision History